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Form PTO-144 (REV. 2-32)		TMENT OF COM		ATTY. DOCKET 8389-013	NO.		SEI	RIAL NO. 19/664,705		
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EXAMINER'S INITIALS	DOCUMENT NUMBER	DATE	NAME		CLASS	SUBC	LASS	FILING IF APP		
RIL	3,517,190	06/23/70	R. W. Asthei	mer			_	·		
22	3,697,185	10/10/72	Kassel et al.					E		
RML	3,796,887	03/12/74	Vincent et al.					ECHNOLO		
RMZ	3,838,925	10/01/74	Marks					5.	1,1	RH
RM	4,126,396	11/21/78	Hartmann et	al.				5	2j _	Ĵ
RAN	4,240,751	12/23/80	Linnecke et al.					CE	_	
pn	4,297,035	10/1981	Bjorklund					114	2001	É
pm	4,426,640	01/17/84	Becconsall e	et al.				~	=	0
PNZ	4,432,649	02/21/84	Krause					28€		~
Ry	4,459,024	07/1984	Gergely					0		
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RR	25 21 934 B2	03/1978	Germany						1	
RN	41 10 095 A1	10/1992	Germany						√	
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Rm	58-213237	12/1983	Japan			-			1	
			cluding Author,							
Rh.	H. Tai, K. Yaman Simultanious Det with Optical Fiber 1992.	ection of M	lethane and A	cetylene by	/ Using I	Diode	Lase	ers Co	uple I–8(∌d 07,
pn	G.I. Mackay, S.D. Nadler, D.R. Karecki, H.I. Schiff, J.W. Butler, C.A Gierczak and G. Jesion, "Dynamometer Intercomparison of Automobile Exhaust Gas CO/CO ₂ Ratios and Temperature Between On-Board Measurements and a Remote Sensing Near									

EXAMINER:

DATE CONSIDERED:

4 May 2001

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw Line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Infrared Diode Laser System", Unisearch Interim Phase 1b Report to the

Laboratory, Golden, CO, contract VE-8-2 August 1994.

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INFO	INFORMATION DISCLOSURE STATEMENT BY APPLICANT				APPLICANT Shachar Nadler				
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1m	4,489,239	12/1984	Grant et al.						
pr	4,516,858	05/14/85	Gelbwachs						
ban	4.518.861	05/1985	Krempl et al.						

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Ferree

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R	2 245 058	12/1991	United Kingdom			
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Rn	93/15566	08/1993	WIPO			

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Form PTO-1449 (REV. 2-32) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. 8389-013

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pn	4,934,816	06/1990	Silver et al.						
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pn-	5,002,391	03/26/91	Wolfrum et al.						
Rn	5,015,843	05/14/91	Seitz et al.						
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Rn	5,047,639	09/10/91	Wong						
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p-	5,275,553	01/04/94	Frish et al.							
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B~	H.I. Schiff, S.D. N Instruments Base Environmental a	ed on Near	Infrared Dioc	de Lasers",	Optical	Sensir	ng fo	r	94.	
R	Environmental and Process Monitoring, McLean, Virginia, November 7–10, 1994. J. Bechara, D.R. Karecki, G.I. Mackay, H.I. Schiff, and S.D. Nadler, "Chemical Analysis of Gases with Tunable Diode Lasers", Reprinted from: New Technologies for Low Emissions Vehicle Testing (SP-1014), International Congress & Exposition, Detroit, Michigan, February 28 - March 3, 1994.									
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*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw Line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant..

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Pr	Henrik Ahlberg, S spectroscopy for Spectroscopy Eur	n situ amn ope 1994.	nonia monitor	ing, LASER	SPECT	ROS	COP.	Y 	
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RS	H.I. Schiff, "The M Blackwell Scientif					-Base	ed Ins	strume	ntation",
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